

Search Notes

Application/Control No.

10/807,541

Examiner

Chris C. Chu

Applicant(s)/Patent und r
Reexamination

SHIOZAWA ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	685, 686 and 777	1/19/2005	C.C.
438	108 & 109	1/19/2005	C.C.
361	760	1/19/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB; and USOCR;	1/19/2005	C.C.